

L Number	Hits	Search Text	DB	Time stamp
1	12	((("5871659") or ("5719080") or ("6221784") or ("5998821") or ("5423941") or ("6583020")).PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:03
3	10	("4310380" "4484978" "4666555" "4726879" "4741799" "5316616" "5358601" "5433823" "5658472" "5759921").PN.	USPAT	2004/05/28 09:40
4	27	("4763181" "4784969" "4792834" "4794434" "5006910" "5012308" "5065273" "5097381" "5119155" "5168366" "5170243" "5170372" "5187566" "5200354" "5250829" "5309008" "5315543" "5349218" "5362663" "5363327" "5372966" "5414285" "5432365" "5442211" "5508541" "5512767" "5528062").PN.	USPAT	2004/05/28 09:42
5	5	("4969022" "4990463" "5028558" "5096854" "5162881").PN.	USPAT	2004/05/28 09:46
6	2468	257/301-305,534,599.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:04
7	1999	438/242,243,386,255,398,665,964.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:06
8	4239	257/301-305,534,599.ccls. or 438/242,243,386,255,398,665,964.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:06
9	139	(257/301-305,534,599.ccls. or 438/242,243,386,255,398,665,964.ccls.) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:36
10	133	((257/301-305,534,599.ccls. or 438/242,243,386,255,398,665,964.ccls.) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))) and etch\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:36
11	3	("5994197" "6251734" "6255160" "2001/0044190").PN.	USPAT	2004/05/28 10:21
12	3	("5831301" "5945707" "6074909").PN.	USPAT	2004/05/28 10:25
13	2	("6458671").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:34
14	5	("5831301" "6074954" "6281069" "6297088" "6312982").PN.	USPAT	2004/05/28 10:31
15	344586	257/\$.ccls. 438/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:35
16	323	(257/\$.ccls. 438/\$.ccls.) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:42
17	303	((257/\$.ccls. 438/\$.ccls.) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))) and etch\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 11:36

18	137	((257/\$.ccls. 438/\$.ccls.) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))) and etch\$3) and collar	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 10:37
19	5	("5047815" "5358891" "5867420" "5869384" "5933748").PN.	USPAT	2004/05/28 10:45
20	1	((257/\$.ccls. 438/\$.ccls.) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))) and (etch\$3 with (silicon near fluoride near oxygen))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 11:37
21	2	(257/\$.ccls. 438/\$.ccls.) and (etch\$3 with (silicon near fluoride near oxygen))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 11:38
22	7	(etch\$3 with (silicon near fluoride near oxygen))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:19
23	20	silicon near fluoride near oxygen	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:16
24	8	(etch\$3 same (silicon near fluoride near oxygen))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:39
25	11	etch\$3 with (by near product)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:41
26	1218	etch\$3 with by-product	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:49
27	3	(etch\$3 with by-product) and (((trench groove) near capacitor\$1) with (STI (trench near isolation))))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:49
28	2081	etch\$3 with (byproduct by-product (by adj product))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:49
29	5	(etch\$3 with (byproduct by-product (by adj product))) and (((trench groove) near capacitor\$1) with (STI (trench near isolation))))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:00
30	7	("5592412" "5605600" "5665622" "5674409" "5851926" "6103585" "6127278").PN.	USPAT	2004/05/28 12:52
31	1	measure\$4 near employ\$3 near interferometry	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 12:59

32	112	employ\$3 near interferometry	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:07
33	1	(employ\$3 near interferometry) and (etch\$3 with (byproduct by-product (by adj product)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:00
34	1	(employ\$3 near interferometry) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:04
35	94	(employ\$3 near interferometry) and measure\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:02
36	1	((employ\$3 near interferometry) and measure\$4) and (optical near emission near spectroscopy)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:03
37	575	optical near emission near spectroscopy	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:03
38	1	(employ\$3 near interferometry) and (optical near emission near spectroscopy)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:04
39	2	(optical near emission near spectroscopy) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:07
40	347	signal near5 interferometry	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:07
41	2	(signal near5 interferometry) and (((trench groove) near capacitor\$1) with (STI (trench near isolation)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/28 13:07